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Investigation of KBiFe_2O_5 as a Photovoltaic Absorber

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Abstract

KBiFe_2O_5 (KBFO) was grown by pulsed laser deposition (PLD) on SrTiO_3 (001) (STO), 1 at% Nb- SrTiO_3 (001) (Nb-STO) and MgAl_2O_4 (001) (MAO). In the case of MAO substrate, epitaxial growth is obtained. As its bandgap is relatively low (1.6 eV in the bulk), KBFO is a promising candidate for oxide photovoltaics. In this work we examine the growth of KBFO by PLD by looking at its structure and composition and we investigate the optical properties of the films obtained. A photovoltaic architecture based on KBFO films is proposed and a solar cell behaviour based on KBFO absorber is obtained.

Keywords: thin film; oxide; pulsed laser deposition; solar cell; photovoltaics

Introduction

Thin film solar cells in industry are mainly based on CdTe, amorphous Si and CuInGa(Se,S)₂ (CIGS). In recent times research on hybrid perovskites expanded exponentially, with solar cell power conversion efficiencies above 21%. This proves that research on novel materials for solar cells can be quite successful and should be maintained. Standard solar cells are based on a pn-junction, however ferroelectric solar cells have emerged with a record conversion efficiency in Bi₂FeCrO₆ of 8.1% (1,2,3). In this type of solar cell, there is no need for a pn-junction and the charge separation can originate from the polarization due to the ferroelectricity (4). The most studied ferroelectric material for its photoelectric properties is BiFeO₃ (5). It was discovered that open circuit voltages of more than a dozen volts could be obtained with this material, and that it is linked to the ferroelectric domain walls (6). Still, ferroelectric solar cell efficiencies with BiFeO₃ are generally much below 1% and the BiFeO₃ bandgap of around 2.6 eV is not ideal for the solar spectrum (7). In fact, oxides with a bandgap suitable for the solar spectrum around 1.3 eV are scarce. Examples of such oxides are 1.1 eV for LaVO₃ (8), 1.2 eV for BiMnO₃ (9), 1.2 eV for CuO (10) and 1.5 eV for Co₃O₄ (11), but these examples provided low solar cell conversion efficiencies pointing out that other parameters than the bandgap must be taken into account to provide efficient solar cells, such as carrier density and carrier diffusion length. Therefore alternative materials are welcome.

In this perspective, KBiFe₂O₅ (KBFO) was reported in 2013 as a new ferroelectric compound with a bandgap of 1.6 eV and a high Curie temperature of 780 K (12). Measurements on single crystal KBFO contacted with Ag electrodes led to a high open circuit voltage (V_{oc}) of 9.1 V and a short-circuit current density (J_{sc}) of around 15 $\mu\text{A}/\text{cm}^2$ (12). Other studies on bulk KBFO exhibited a photoresponse with $V_{oc}=2.04$ V, $J_{sc}=20.7$ $\mu\text{A}/\text{cm}^2$ (13), and $V_{oc}=-0.5$ V and a short circuit current of 20 nA (14). It was argued that the short-circuit current density was limited due to the fact that measurements were made on single crystal KBFO. Thus, the synthesis of KBFO layers using a sol-gel process and spin-coating has been reported (15,16). KBFO has a brownmillerite type-structure A₂B₂O₅ with lattice parameters $a=0.7984$ nm, $b=1.1819$ nm, $c=0.5739$ nm with an orthorhombic space group P2₁cn (12). In addition, magnetoelectric and photovoltaic (PV) effects in KBFO were studied theoretically in (17).

In the present work, we investigate the growth of KBFO in the form of thin films using the pulsed laser deposition (PLD) method. PLD is known to result in high quality materials, in particular in the case of an epitaxial process. The structural and optical properties of the deposited KBFO films are reported.

Experimental procedure

The KBFO target used for the PLD process was prepared as follows. First potassium nitrate (4.936 g), bismuth (III) nitrate pentahydrate (26.973 g), and iron (III) nitrate nonahydrate (27.234 g) are poured in deionized water (~100 ml). Films deposited from a stoichiometric composition were shown to be largely K and Bi deficient. Therefore targets were made with an excess of K and Bi in the following proportions: K 1.45:Bi 1.65:Fe 2. Citric acid (14 g) is dissolved in the solution together with ethylene glycol (30 ml, the Pecchini method is used). The excess of water is evaporated and a viscous liquid without precipitate appears. This compound is pre-calcinated in a furnace at 350 °C for two hours, mechanically ground in a mortar, and further calcinated at 700 °C for 1 h in air. The obtained powder is ground again, pressed into a pellet and sintered at 700°C for 1 h in air. The target is thoroughly polished, as Rutherford Backscattering (RBS) has indicated that the surface of the target after sintering is mainly composed of K. It was checked that the composition of the polished target matches the stoichiometry of the precursors.

The PLD process was performed using a KrF laser with 10 Hz repetition rate and a laser fluence of around 2 J/cm² on the target. The substrates used for deposition were SrTiO₃ (001) (STO) (insulating, thickness 0.5 mm), 1 at% Nb-SrTiO₃ (001) (Nb-STO) (resistivity 0.003 Ω·cm, thickness 0.5 mm) and MgAl₂O₄ (001) (MAO) (insulating, thickness 0.5 mm). The deposition was carried out at 700 °C under an oxygen pressure of 10⁻² mbar. KBFO film thicknesses were in the 50-100 nm range. The as-grown film was cooled down under the same atmosphere at a rate of 10°C/min until 300°C, below this temperature it was naturally cooled down until room temperature. Around 30 samples were deposited for the study.

The crystalline structure of the KBFO films was analyzed by X-ray diffraction using a Rigaku SmartLab diffractometer equipped with a monochromatic source delivering a Cu K_{α1} incident beam (45 kV, 200 mA, 0.154056 nm). X-ray θ -2 θ and reflectivity were performed in order to look for the film structure, check the presence of spurious phases, and determine the film thickness. Scanning electron microscopy (SEM) was performed with a Gemini 500-ZEISS apparatus. Rutherford backscattering was used to determine atomic composition and thickness of the layers, using 1.5 MeV He⁺ particles provided by the Van De Graaff Accelerator (HVEE KN4000) facility of ICube. Transmission electron microscopy (TEM) was performed with a FEI TALOS F200X TEM/STEM with ChemiSTEM technology (X-FEG and SuperX EDS with four silicon drift detectors) operated at 200 kV. It was used for microstructure characterization and energy-dispersive X-ray spectroscopy (EDS) chemical mapping. The optical measurements of the KBFO films were investigated using a Perkin-Elmer Lambda 950 spectrophotometer using a 150 mm integrating sphere. Their ferroelectric properties were investigated by the Piezoresponse Force Microscopy (PFM) technique using a Bruker Icon QNM

microscope. For PV measurements, I-V characteristics were carried out at room temperature using an Oriel Solar Simulator in AM1.5G conditions and a Keithley 2461 SourceMeter.

Results

Firstly KBFO was deposited by PLD on SrTiO₃ (001) (STO). The XRD θ - 2θ pattern was recorded as shown in Fig. 1a). STO is cubic with a lattice parameter of 0.3905 nm. Because there is no direct match between the STO substrate and KBFO, two different orientations are observed, (020) and (400). In the search for more suitable substrates, MgAl₂O₄ (001) (MAO) was used. It is also cubic but with a lattice parameter of 0.8083 nm. Fig. 1b) shows the corresponding XRD θ - 2θ pattern. The two film peaks observed can be attributed to KBFO (400) and (800) and no other parasitic peaks are observed within the limits of the technique available. The possible epitaxial relationship is KBFO [010](100) // MAO [110](001), confirmed by TEM observation (see Supporting Information (SI) Fig. S1). In this situation the KBFO *b* and *c* lattice parameters are compressed in plane by 3.4% and 0.5% respectively compared to the bulk, which generates an extension of the *a* lattice parameter. Hence according to XRD the KBFO *a* lattice parameter is 0.8321 nm which is about 4.2% larger than the bulk. It should be noted that the KBFO (200) and (600) reflections are absent, which could originate from strain or defects, and indicates that the film deviates from the P2₁cn space group of the bulk (12).

SEM analysis performed on KBFO on STO (001) revealed a growth with elongated rectangular shapes while smoother films could be obtained on MAO (001) (see SI Fig. S2). Analysis of the stoichiometry by EDS showed that the sample is composed of K₁Bi₁Fe_{3.3}O_y (SI Fig. S3). However, the measurement of stoichiometry in this case is not very accurate. This is due to the overlap with Sr and Ti signal from the substrate and also due to the small thickness of the sample (60 nm). Inaccuracy of the EDS analysis has been previously observed in similar materials based on Bi (3,18). In order to better account for the stoichiometry we performed RBS analysis on a KBFO//STO (001) film as shown in Fig. 2. The analysis for the spectrum using the SIMNRA tool indicated a stoichiometry of K_xBi₁Fe_{2.2}O_y while the stoichiometry of K and O could not be determined in this analysis. The uncertainty of the values obtained for stoichiometry by RBS is 5 % for each element. Therefore we are confident that the stoichiometry obtained in Fe is not far from the desired K₁Bi₁Fe₂O₅ material.

In order to better understand the growth of KBFO, TEM was performed. Figure 3 shows TEM observations of a KBFO thin film on MAO (001) along the MAO [100] zone axis. High epitaxial quality thin film is observed by TEM (Figure 3c, SI Figure S4, S5). The electron diffraction pattern (DP) (Figure 3b) and high-resolution TEM (HR-TEM) image show the great lattice matching between film and

substrate and confirm the epitaxial relationship proposed above. However, further work will be to accurately determine atomic positions for comparison with the proposed bulk structure in (12). The EDS mapping shows Bi segregation in the film (Figure 3d, SI Figure S6), while K and Fe are evenly distributed in the film.

We now focus on the optical properties of the films. Figure 4 shows the optical absorption properties of the MAO (001) substrate and a 60 nm thick KBFO film on MAO (001). The absorbance was not corrected for reflection. It shows that despite the low thickness the film is absorbing well in the 200-600 nm region. The Tauc plot is shown in the inset of Figure 4, showing a direct bandgap of around 2.3 ± 0.1 eV. This value is larger than the value obtained for bulk KBFO (1.6 eV) (12) but slightly lower than KBFO thin films fabricated by chemical solution deposition (2.5 eV) (15). The absorption coefficient was found to be $3.3 \cdot 10^4 \text{ cm}^{-1}$ at 600 nm which is comparable to the absorption coefficient of amorphous Si.

After having confirmed the structure and optical properties of the KBFO films, electrical properties were looked into. It was found that the in-plane resistivity or carrier properties could not be determined in the films grown on STO (001) or MAO (001) because they were found to be insulating. PFM measurements did not exhibit any sign of ferroelectricity or piezoelectricity with KBFO films grown on Nb-STO in order to have a conductive substrate. Such KBFO films on Nb-STO were found to be of better surface quality than with the STO substrate, with a root-mean-square roughness of 6 nm over $1 \mu\text{m}^2$. The same KBFO on Nb-STO configuration was further covered with indium tin oxide (ITO) 1 mm^2 pads deposited by magnetron sputtering through a mask. A tungsten tip was applied on top of the pad and the backside was contacted with silver paste. Figure 5 shows the current-voltage characteristics obtained in dark and under 1 sun. The inset of Figure 5 shows that a rectifying behaviour is observed. When focussing on PV properties the short-circuit current density, open circuit voltage and fill factor were $2.8 \mu\text{A}/\text{cm}^2$, 155 mV and 42% respectively. This short-circuit current density is about 5-7 times lower than references (12) and (13). It should be noted that the active area defined to convert the short-circuit current into a short-circuit current density has been taken as 1 mm^2 , which is reasonable as the KBFO film is highly resistive and therefore the areas outside the ITO pad cannot contribute to the current. The power conversion efficiency is $1.8 \cdot 10^{-4} \%$. While previous solar cells based on KBFO were obtained in bulk KBFO, here we demonstrate that similar performance in terms of short-circuit current density is obtained in KBFO thin films, which are more practical for possible applications. KBFO single crystal in Ref. (12) allowed a high V_{oc} of 9.1 V while here it is only 155 mV. We believe that this is directly due to the structure of the KBFO film on

Nb-STO that provides multiple orientations of KBFO. The PV properties are low but encouraging because KBFO grown on Nb-STO did not provide epitaxy or high quality deposition. The short-circuit current remained the same after applying pulses of ± 8 V between Nb-STO and ITO. This was expected because no ferroelectricity of KBFO films could be demonstrated. We attempted growing KBFO/SrRuO₃//MAO (001) stacks. The aim was to obtain epitaxy of KBFO as in the case of KBFO//MAO (001), but this time with a SrRuO₃ conductive electrode instead of the electrode of Nb-STO (001). However no peaks of SrRuO₃ or KBFO could be observed by XRD. Alternative contact materials on top and bottom of KBFO must therefore be investigated.

Conclusions

We attempted to grow KBFO by PLD and obtained epitaxial films, showing high quality deposition as evidenced by XRD and TEM. To our knowledge this is the first time that epitaxy of KBFO is obtained. Previous work on KBFO films obtained by sol-gel and spin coating were polycrystalline (15, 16). If the bandgap found of 2.2 eV is relatively high compared to the optimum for the solar spectrum for a single bandgap solar cell, the photoactive properties of KBFO have been clearly demonstrated which is a further step in polar functional materials. In order to further investigate the photovoltaic properties of the material, a suitable epitaxial conductive buffer layer on MAO (001) should be found in order to provide an electrode for KBFO. Our results are encouraging for future implementation of such oxide absorber in photovoltaic technology.

Supporting Information

Sketch showing epitaxial relationship, SEM images, SEM EDX analysis, low magnification TEM images, high magnification TEM images, TEM EDS mappings.

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Figure 1: XRD θ - 2θ pattern of a 60 nm thick KBFO thin film grown on STO (001) (a) and MAO (001) (b) substrates.

Figure 2: RBS yield vs. energy for a 100 nm thick KBFO film on STO (001).

Figure 3: TEM of KBFO film on MAO (001) in the MAO [010] zone axis: a) low-magnification TEM image, b) selected area diffraction patterns (SAED) of thin film and substrate, and c) high-magnification TEM image, d) EDS mapping showing Bi, Fe and Mg.

Figure 4: Optical absorption vs. wavelength of a 60 nm thick KBFO thin film on MAO (001). Inset: the Tauc plot for the same sample for a direct bandgap.

Figure 5: Current density vs. voltage of a KBFO solar cell measured in dark and under 1 sun.